

Application/Control No.	Applicant(s)/Patent under Reexamination
10/677,731	PAE ET AL.
Examiner	Art Unit
Linh T. Nauven	2627

	SEAR	CHED	
Class	Subclass	Date	Examiner
369	44.16	6/21/2006	LN
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Consulted with Wayne Young	6/21/2006	LN		